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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/382,708	KIM ET AL.	
Examiner	Art Unit	
Shengjun Wang	1617	

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Class	Subclass	Date	Examiner
424	70.16,70.1 70.11 70.12	3/19/2005	5~
424	70.15,43	3/19/2005	5~
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Class	Subclass	Date	Examiner
424	70.16	3/19/2005	5~
424	70.1	3/19/2005	Su
424	70.11	3/19/2005	5~
424/70.13	3,70.15,43	3/19/2005	y~

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inventor search		3/19/2005	5.
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